56 ∏ D4

55 D3

54 D2

52 D1

51 D0

50 D27

48 YOM

47 Y0P

46 ¶ Y1M

45 Y1P

42 Y2M

41 Y2P

38**∏** Y3M

37 1 Y3P

49 LVDSGND

44 LVDSV_{CC}

43 LVDSGND

40 CLKOUTM

39 CLKOUTP

36 LVDSGND

35 PLLGND

34 PLLV_{CC}

33 PLLGND

32 SHTDN

31 T CLKIN

30 D26

29 **GND**

53 GND

DGG PACKAGE (TOP VIEW)

Vcc L

D5 Π 2

D6 **∏** 3

D8 ∏

D9 **1** 7

Vcc [9

D13 **∏**

D15 Π

CLKSEL 17

D17 ∏

D19

GND

D20

D21

D22

D23

 V_{CC}

D25

D24 [

D11 **∏** 10

D12 | 11

GND [] 13

D14 Π 14

D16 **∏** 16

D18 **∏** 19

D10

 Π_4 GND ∏

5

6

8

12

15

18

20 П

21

22

23

24

25

26

27

28

D7



- Suited for SVGA, XGA, or SXGA Display **Data Transmission From Controller to Display With Very Low EMI**
- 28 Data Channels and Clock-In Low-Voltage
- 4 Data Channels and Clock-Out **Low-Voltage Differential**
- Operates From a Single 3.3-V Supply With 250 mW (Typ)
- **ESD Protection Exceeds 6 kV**
- **5-V Tolerant Data Inputs**
- Selectable Rising or Falling Edge-Triggered Inputs
- Packaged in Thin Shrink Small-Outline Package With 20-Mil Terminal Pitch
- Consumes Less Than 1 mW When Disabled
- Wide Phase-Lock Input Frequency Range . . . 31 MHz to 68 MHz
- No External Components Required for PLL
- **Outputs Meet or Exceed the Requirements** of ANSI EIA/TIA-644 Standard
- Improved Replacement for the DS90C581

description

The SN75LVDS83 FlatLink transmitter contains four 7-bit parallel-load serial-out shift registers, a

7× clock synthesizer, and five low-voltage

differential-signaling (LVDS) line drivers in a single integrated circuit. These functions allow 28 bits of single-ended low-voltage TTL (LVTTL) data to be synchronously transmitted over five balanced-pair conductors for receipt by a compatible receiver, such as the SN75LVDS82. The SN75LVDS83 can also be used in 21-bit links with the SN75LVDS86 receiver.

When transmitting, data bits D0 through D27 are each loaded into registers upon the edge of the input clock signal (CLKIN). The rising or falling edge of the clock can be selected by way of the clock select (CLKSEL) terminal. The frequency of CLKIN is multiplied seven times (7×) and then used to unload the data registers in 7-bit slices and serially. The four serial streams and a phase-locked clock (CLKOUT) are then output to LVDS output drivers. The frequency of CLKOUT is the same as the input clock, CLKIN.

The SN75LVDS83 requires no external components and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with the data transmission transparent to the user. The only user intervention is the possible use of the shutdown/clear (SHTDN) active-low input to inhibit the clock and shut off the LVDS output drivers for lower power consumption. A low-level signal on SHTDN clears all internal registers to a low level.

The SN75LVDS83 is characterized for operation over free-air temperature ranges of 0°C to 70°C.



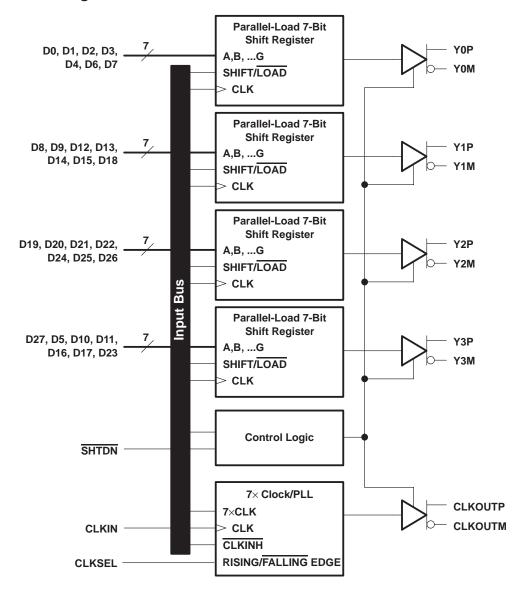
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ISTRUMENTS

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functional block diagram





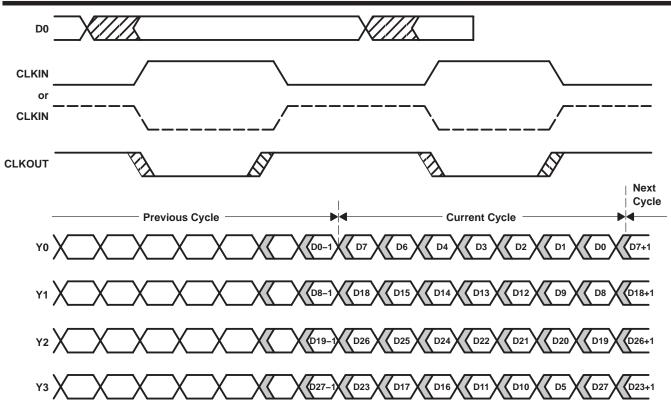
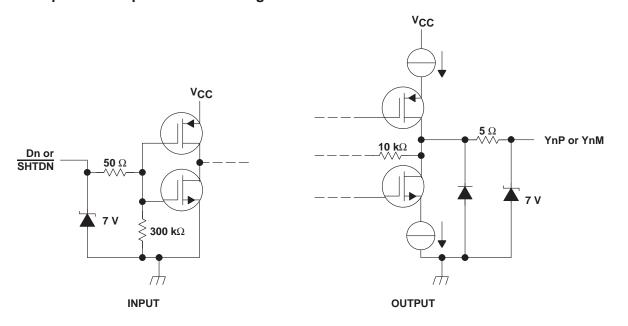


Figure 1. SN75LVDS83 Load and Shift Timing Sequences

equivalent input and output schematic diagrams



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC} (see Note 1)	–0.5 V to 4 \
Output voltage range, VO (all terminals)	
Input voltage range, V _I (all terminals)	0.5 V to 5.5 \
Continuous total power dissipation	See Dissipation Rating Table
Storage temperature range, T _{stg}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

NOTE 1: All voltage values are with respect to the GND terminals.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR [‡]	T _A = 70°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING
DGG	1377 mW	11.0 mW/°C	822 mW

[‡] This is the inverse of the junction-to-ambient thermal resistance when board mounted and with no air flow.

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}	3	3.3	3.6	V
High-level input voltage, VIH	2			V
Low-level input voltage, V _{IL}			0.8	V
Differential load impedance, Z _L	90		132	Ω
Operating free-air temperature, T _A	0		70	°C

timing requirements

		MIN	NOM I	VIAX	UNIT
t _C	Cycle time, input clock	14.7		32.3	ns
t _W	Pulse duration, high-level input clock	0.4 t _C	(0.6 t _C	ns
t _t	Transition time, input signal			5	ns
t _{su}	Setup time, data, D0 – D27 valid before CLKIN↑ or CLKIN↓ (see Figure 2)	3			ns
th	Hold time, data, D0 – D27 valid after CLKIN↑ or CLKIN↓ (see Figure 2)	1.5			ns

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP [†]	MAX	UNIT
V _{IT}	Input threshold voltage			1.4		V
IVODI	Differential steady-state output voltage magnitude		247		454	mV
Δ V _{OD}	Change in the steady-state differential output voltage magnitude between opposite binary states	R_L = 100 Ω, See Figure 3			50	mV
V _{OC(SS)}	Steady-state common-mode output voltage	0 5: 0	1.125		1.375	V
V _{OC(PP)}	Peak-to-peak common-mode output voltage	See Figure 3			150	mV
lιΗ	High-level input current	V _{IH} = V _{CC}			25	μΑ
I _I L	Low-level input current	V _{IL} = 0			±10	μΑ
		$V_{O(Yn)} = 0$			±24	mA
los	Short-circuit output current	V _{OD} = 0			±12	mA
loz	High-impedance state output current	$V_O = 0$ to V_{CC}			±10	μΑ
		Disabled, All inputs at GND			280	μΑ
I _{CC}	Quiescent supply current	Enabled, $R_L = 100 \Omega$, Gray-scale pattern (see Figure 4), $V_{CC} = 3.3 \text{ V}$, $t_{C} = 15.38 \text{ ns}$		72	90	mA
		Enabled, $R_L = 100 \Omega$, Worst-case pattern (see Figure 5), $t_C = 15.38 \text{ ns}$		85	110	mA
Cl	Input capacitance			3		pF

 $[\]dagger$ All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended operating conditions (unless otherwise noted)

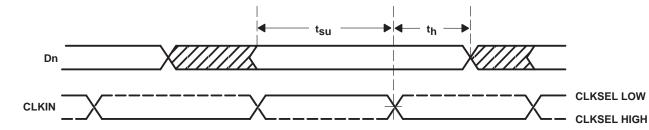
	PARAMETER	TEST CONDITIONS	MIN	TYP [†]	MAX	UNIT
t _{d0}	Delay time, CLKOUT \uparrow to serial bit position 0		-0.2	0	0.2	ns
^t d1	Delay time, CLKOUT↑ to serial bit position 1		$\frac{1}{7}t_{C} - 0.2$		$\frac{1}{7}t_{C} + 0.2$	ns
t _{d2}	Delay time, CLKOUT↑ to serial bit position 2		$\frac{2}{7}t_{C} - 0.2$		$\frac{2}{7}t_{C} + 0.2$	ns
t _{d3}	Delay time, CLKOUT↑ to serial bit position 3	$t_C = 15.38 \text{ ns } (\pm 0.2\%),$ Input clock jitter < 50 ps [‡] , See Figure 6	$\frac{3}{7}t_{C}-0.2$		$\frac{3}{7}t_{C} + 0.2$	ns
t _{d4}	Delay time, CLKOUT↑ to serial bit position 4	Imput clock jitter < 50 ps+, See Figure 6	$\frac{4}{7}t_{C}-0.2$		$\frac{4}{7}t_{C} + 0.2$	ns
t _{d5}	Delay time, CLKOUT↑ to serial bit position 5		$\frac{5}{7}t_{C}-0.2$		$\frac{5}{7}$ t _C + 0.2	ns
^t d6	Delay time, CLKOUT↑ to serial bit position 6		$\frac{6}{7}t_{C}-0.2$		$\frac{6}{7}$ t _C + 0.2	ns
tsk(o)	Output skew, $t_n - \frac{n}{7}t_C$		-0.2		0.2	ns
t _{d7}	Delay time, CLKIN↓ to CLKOUT↑	$t_C = 18.51 \text{ ns } (\pm 0.2\%),$ Input clock jitter < 50 ps [‡] , See Figure 6	3.75	5.6	7.75	ns
		$t_{\rm C}$ = 15.38 ± 0.75 sin (2 π 500E3t) + 0.05 ns, See Figure 7		±70		ps
$\Delta t_{C(O)}$	Cycle time, output clock jitter§	$t_{\rm C}$ = 15.38 ± 0.75 sin (2 π 3E6t) + 0.05 ns, See Figure 7		±187		ps
t _W	Pulse duration, high-level output clock			$\frac{4}{7}t_{C}$		ns
t _t	Transition time, differential output (t _r or t _f)	See Figure 3	260	700	1500	ps
t _{en}	Enable time, SHTDN↑ to phase lock (Yn valid)	See Figure 8		1		ms
tdis	Disable time, SHTDN↓ to off state (CLKOUT low)	See Figure 9		250		ns

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

^{‡ |}Input clock jitter| is the magnitude of the change in the input clock period.

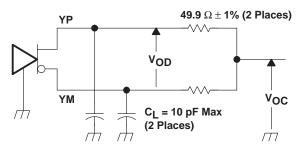
[§] Output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 15000 cycles.

PARAMETER MEASUREMENT INFORMATION



NOTE A: All input timing is defined at 1.4 V on an input signal with a 10%-to-90% rise or fall time of less than 5 ns.

Figure 2. Setup and Hold Time Waveforms



NOTE A: The lumped instrumentation capacitance for any single-ended voltage measurement is less than or equal to 10 pF. When making measurements at YP or YM, the complementary output is similarly loaded.

(a) SCHEMATIC

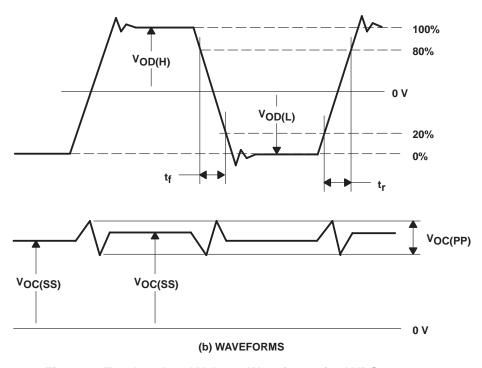
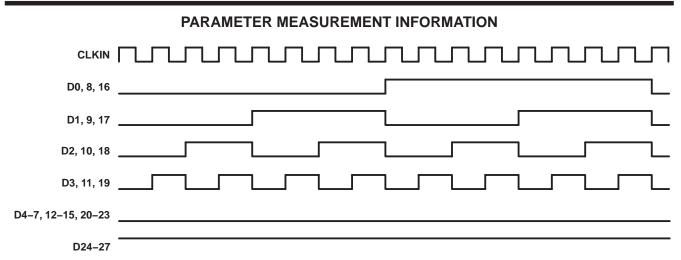


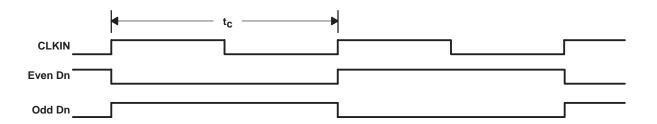
Figure 3. Test Load and Voltage Waveforms for LVDS Outputs





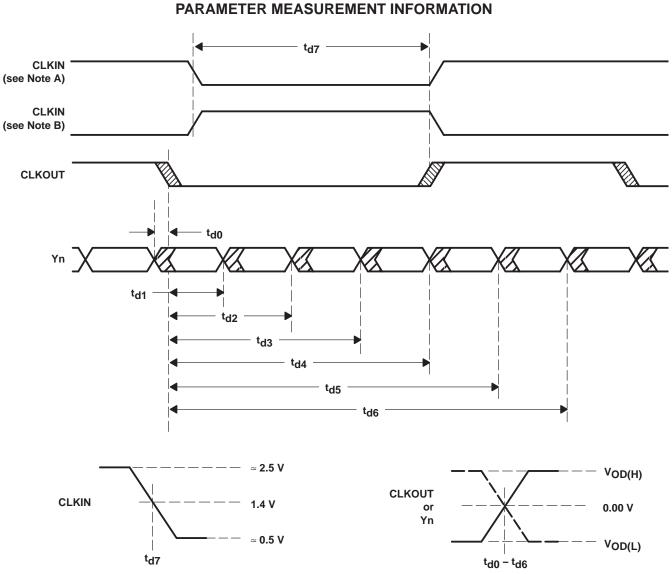
NOTE A: The 16-grayscale test-pattern test device power consumption for a typical display pattern. Pattern with CLKSEL low shown.

Figure 4. 16-Grayscale Test-Pattern Waveforms



NOTE A: The worst-case test pattern produces nearly the maximum switching frequency for all of the LVDS outputs. Pattern with CLKSEL low shown.

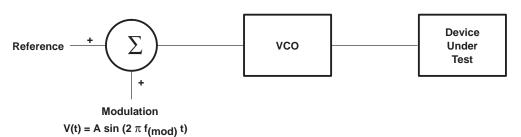
Figure 5. Worst-Case Test-Pattern Waveforms



NOTES: A. This wave form is valid when CLKSEL is low.
B. This wave form is valid when CLKSEL is high.

Figure 6. SN75LVDS83 Timing Waveforms

PARAMETER MEASUREMENT INFORMATION



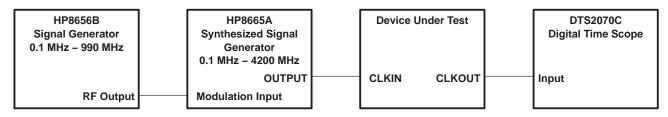


Figure 7. Output Clock Jitter Testing

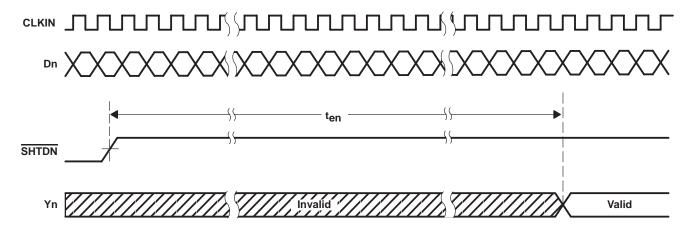


Figure 8. Enable Time Waveforms

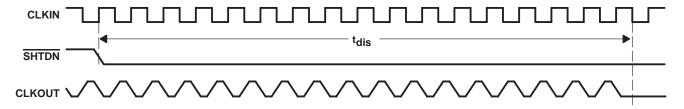


Figure 9. Disable Time Waveforms

TYPICAL CHARACTERISTICS

AVERAGE SUPPLY CURRENT VS

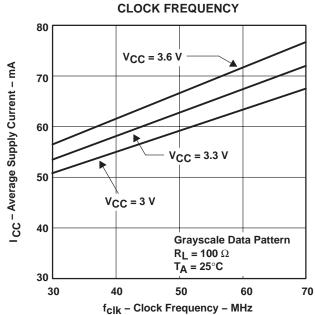


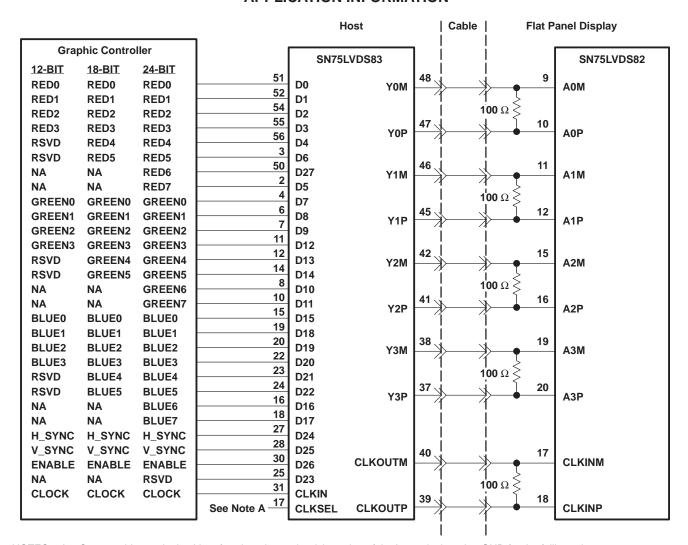
Figure 10

ZERO-TO-PEAK OUTPUT JITTER

٧S **MODULATION FREQUENCY** 200 180 160 Zero-to-Peak Output Jitter - ps 140 120 100 80 60 40 Input jitter = 750 $\sin (6.28 f_{(mod)} t) ps$ $V_{CC} = 3.3 V$ 20 T_A = 25°C 0 0.5 1.5 3 0 f_(mod) - Modulation Frequency - MHz

Figure 11

APPLICATION INFORMATION

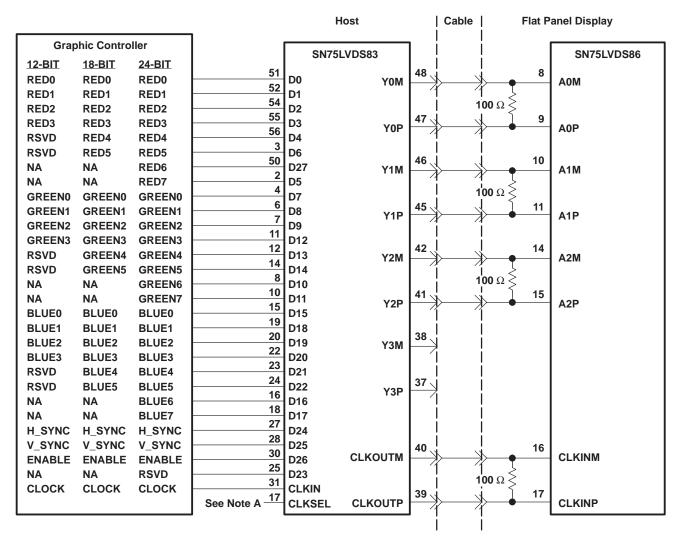


NOTES: A. Connect this terminal to $V_{\hbox{CC}}$ for triggering to the rising edge of the input clock and to GND for the falling edge.

B. The five $100-\Omega$ terminating resistors are recommended to be 0603 types.

Figure 12. 24-Bit Color Host To 24-Bit LCD Panel Display Application

APPLICATION INFORMATION



NOTES: A. Connect this terminal to V_{CC} for triggering to the rising edge of the input clock and to GND for the falling edge.

B. The four $100-\Omega$ terminating resistors are recommended to be 0603 types.

Figure 13. 24-Bit Color Host To 18-Bit LCD Panel Display Application



PACKAGE OPTION ADDENDUM

6-Feb-2020

PACKAGING INFORMATION

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Orderable Device	Status	Package Type	Package Drawing		Package Qty		Lead/Ball Finish	•	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN75LVDS83DGG	NRND	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	SN75LVDS83	
SN75LVDS83DGGG4	NRND	TSSOP	DGG	56	35	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	SN75LVDS83	
SN75LVDS83DGGR	NRND	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	0 to 70	SN75LVDS83	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

6-Feb-2020

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PACKAGE MATERIALS INFORMATION

www.ti.com 29-Sep-2019

TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75LVDS83DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1

www.ti.com 29-Sep-2019



*All dimensions are nominal

Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN75LVDS83DGGR	TSSOP	DGG	56	2000	350.0	350.0	43.0	



SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
 4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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